•	searcr	i wote	5

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/729,569	KUSAKABE ET AL.	
Examiner	Art Unit	
Ellen C. Tran	2134	

	SEAR	CHED	
Class	Subclass	Date	Examiner
235	384	8/4/2005	ECT
713	201	8/4/2005	ECT
380	228	8/4/2005	ECT

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
	·		

SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
USPTO, USPG, EPO, JPO, DERWENT, IBM TECH DES	8/4/2005	ECT
•		
		_